

**Notice of References Cited**

Application/Control No.

10/049,764

Applicant(s)/Patent Under  
Reexamination  
DESSEIN ET AL.

Examiner

Edwin A. León

Art Unit

2833

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,772,222	09-1988	Laudig et al.	439/578
	B	US-5,078,621	01-1992	Nishikawa et al.	439/581
	C	US-6,517,387	02-2003	Huang, Chien Shun	439/680
	D	US-5,180,315	01-1993	Nagashima, Masayuki	439/581
	E	US-6,074,217	06-2000	Maruyama et al.	439/63
	F	US-5,322,453	06-1994	Resnick et al.	439/581
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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